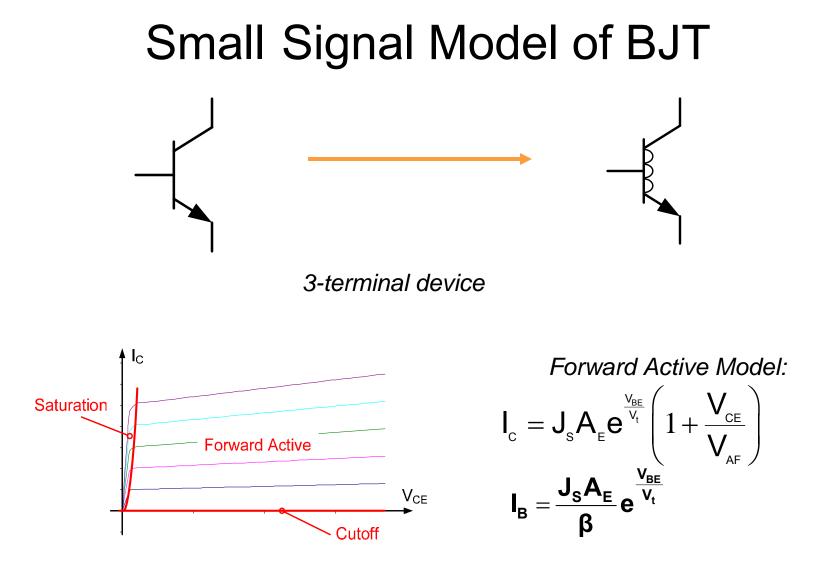
EE 230 Lecture 36

Data Converters

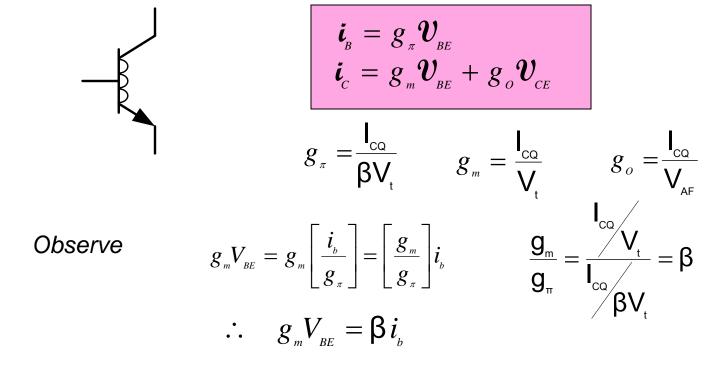
Review from Last Time:

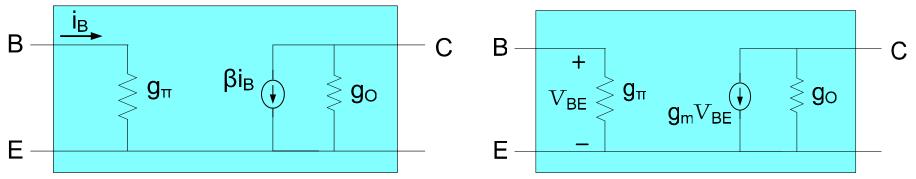


Usually operated in Forward Active Region when small-signal model is needed

Review from Last Time:

Small Signal Model of BJT





Alternate equivalent small-signal models of the BJT

Review from Last Time:

Recall:

Alternative Approach to small-signal analysis of nonlinear networks

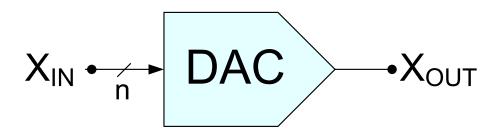
1. Linearize nonlinear devices

(have small-signal model for key devices!)

- 2. Replace all devices with small-signal equivalent
- 3. Solve linear small-signal network

Standard Symbols:

Analog to Digital Converter

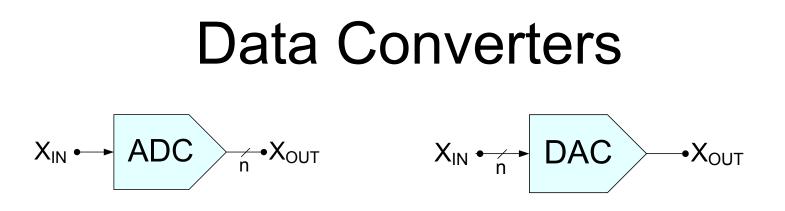


Digital to Analog Converter

Other Symbols:

Analog to Digital Converter

Digital to Analog Converter



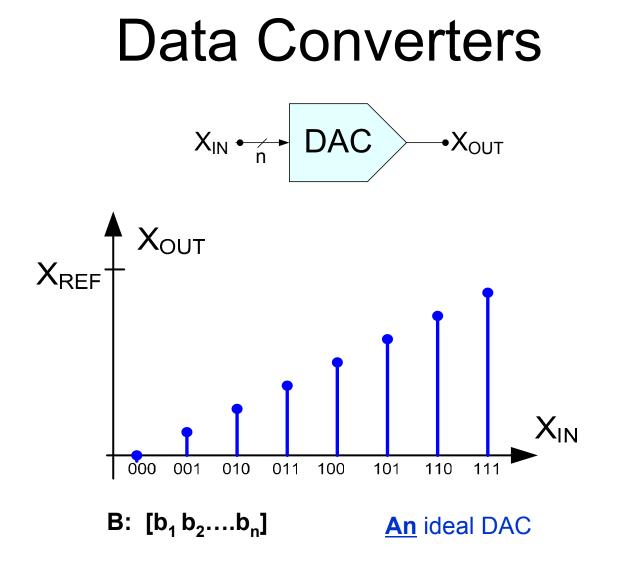
	X _{IN}	X _{OUT}
ADC	Analog	
DAC	Digital	Analog

Analog variables: Voltage, Current, time, charge, occasionally other physical variables

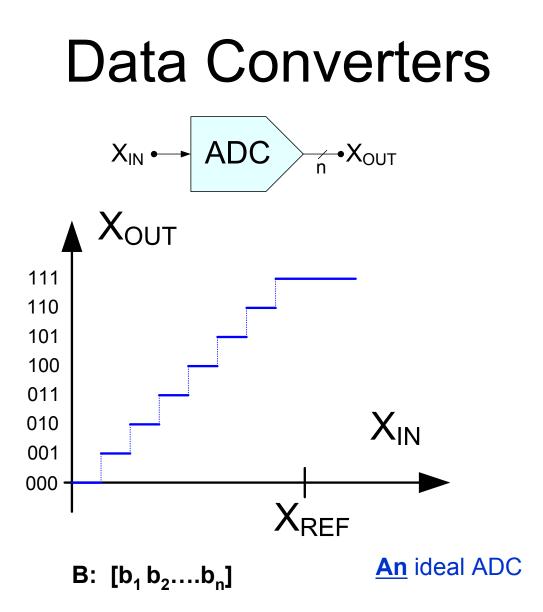
Digital variables: Usually represented in binary form but other forms occasionally used (e.g. gray, Thermometer code)



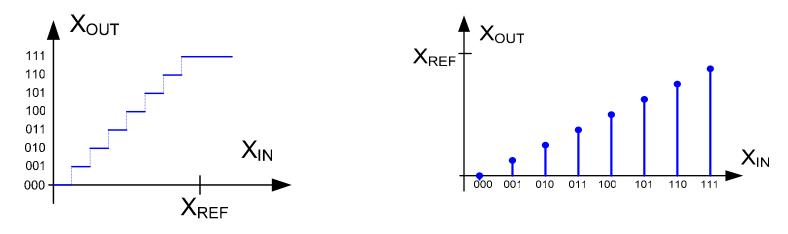
Applications: Dominantly the interfaces between the continuous-time Continuous-amplitude physical environment and a digital system such as a computer, microprocessor, microcontroller, or finite state machine



(Some specific shifted versions of this DAC would also be termed an ideal DAC)



(Some specific shifted versions of this ADC would also be termed an ideal ADC)



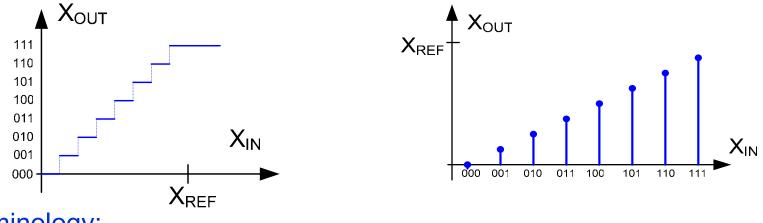
Terminology:

B: [b₁ b₂....b_n]

b₁: Most Significant Bit (MSB)
b_n: Least Significant Bit (LSB)

Resolution: Defines number of distinct levels for DAC or Boolean outputs for ADC. If there are N distinct levels, resolution generally defined as $n = \log_2 N$ thus, $N = 2^n$

 X_{REF} : specifies the full-scale range of the data converter. Input range for ADC or output range for DAC is usually $X_{\text{REF}}\left(\frac{2^{n}-1}{2^{n}}\right) \cong X_{\text{REF}}$



Terminology:

LSB (or X_{LSB}) : Analog change (in input to ADC or output of DAC) corresponding to one LSB digital change

$$X_{LSB} = \frac{X_{REF}}{2^n}$$

Transition Points (for ADC): values of X_{IN} where output changes by 1 LSB (an n-bit ADC has N-1 transition points partitioning input into N distinct intervals)

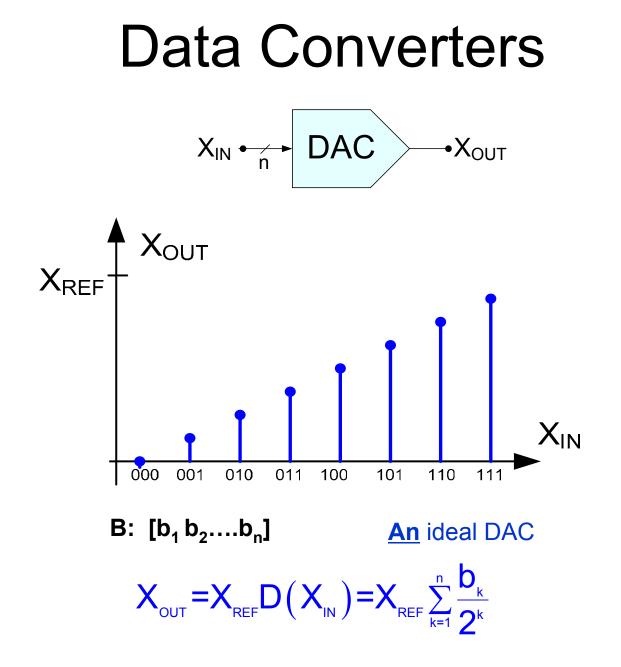
Decimal Equivalent: Decimal equivalent of B: [b₁ b₂....b_n]

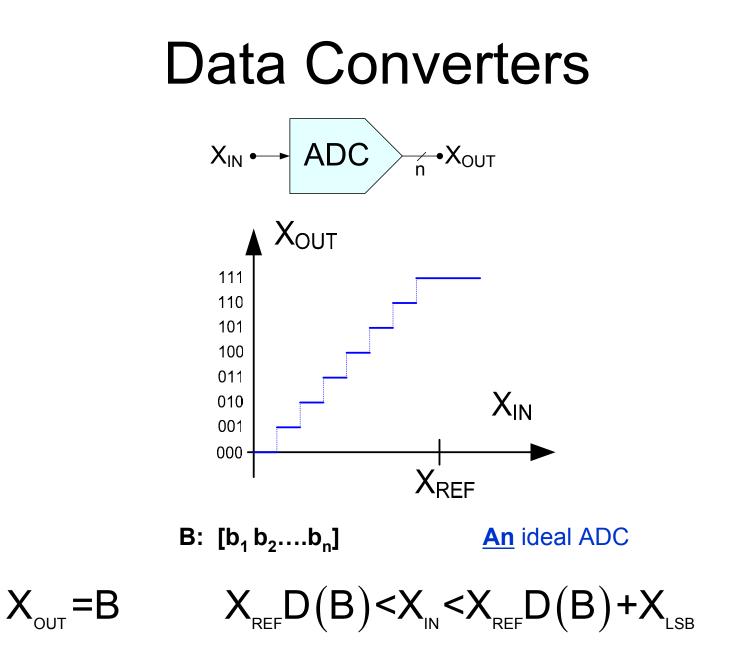
$$D(B) = \left(\frac{b_1}{2} + \frac{b_2}{4} + \dots + \frac{b_n}{2^n}\right) \longrightarrow D(B) = \sum_{k=1}^n \frac{b_k}{2^k}$$

Number of levels for different resolution

n	Ν	
1	2 ¹	2
2	2 ²	4
3	2 ³	8
4	24	16
5	2 ⁵	32
6	2 ⁶	64
7	27	128
8	2 ⁸	256
9	2 ⁹	512

n	Ν	
10	2 ¹⁰	1024
11	2 ¹¹	2048
12	2 ¹²	4096
13	2 ¹³	8192
14	214	16384
15	2 ¹⁵	32768
16	2 ¹⁶	65536
20	2 ²⁰	1,048,576
24	2 ²⁴	16,772,216





Example

Determine V_{LSB} for a 16-bit ADC if X_{REF} is a voltage of 1V.

$$X_{LSB} = \frac{1V}{2^{16}} = 15.25 \mu V$$

Observe X_{LSB} is very small and for a 16-bit ADC, must resolve an input signal to $\pm X_{LSB}/2=\pm7.5\mu V$

Example

Determine the number of bits of resolution, n, required in an ADC if it is to be used in a DMM that has accuracy corresponding to m decimal digits

Resolution of an m-digit DMM is $V_{REF}/10^{m}$

Thus equating the resolution of an ADC represented in binary form to that of the DMM, we obtain the expression χ

 $\frac{V_{\text{REF}}}{2^{n}} = \frac{V_{\text{REF}}}{10^{m}}$ It thus follows that $m = n \log_{10} 2$ Solving for n, we obtain $n = \frac{m}{\log_{10} 2}$ If m=6, n=20 If m=7, n=23+ If $V_{\text{REF}} = 1V$, $V_{\text{LSB}} = 0.95 \mu V$ If $V_{\text{REF}} = 1V$, $V_{\text{LSB}} = 112 n V$

Very high resolution is required in applications such as this!

Discrete implementations of data converters are seldom used

- Not cost effective
- Too large
- Vary difficult to maintain acceptable accuracies of components
- Integrated data converters usually have voltage or current as input or output variables
 - If conversion of other physical units is required, a transducer precedes or follows a voltage or current data converter